

NCEP85T16D-VB Datasheet N-Channel 80 V (D-S) MOSFET

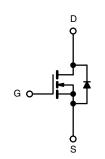
PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}$ (Ω) MAX.	I _D (A)	Q _g (TYP.)		
80	0.0050 at V _{GS} = 10 V	215	94		
	0.0095 at V _{GS} = 7.5 V	205	94		

FEATURES

- Trench power MOSFET
- Maximum 175 °C junction temperature
- Very low Q_{gd} reduces power loss from passing through V_{plateau}
- 100 % R_g and UIS tested







N-Channel MOSFET

APPLICATIONS

- Power supply
 - Secondary synchronous rectification
- DC/DC converter
- Power tools
- Motor drive switch
- DC/AC inverter
- Battery management

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER	SYMBOL	LIMIT	UNIT			
Drain-Source Voltage	V _{DS}	80	V			
Gate-Source Voltage	V _{GS}	± 20	V			
Continuous Drain Correct /T 150 °C)	T _C = 25 °C	I _D	215	A		
Continuous Drain Current (T _J = 150 °C)	T _C = 70 °C	'D	120 ^d			
Pulsed Drain Current (t = 100 μs)	I _{DM}	600				
Avalanche Current	I _{AS}	70				
Single Avalanche Energy ^a $L = 0.1 \text{ mH}$		E _{AS}	245	mJ		
Maximum Power Dissipation ^a	T _C = 25 °C	P _D	375 ^b	W		
Maximum Fower Dissipation -	T _C = 125 °C	- P	125 ^b	VV		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	-55 to +175	°C			

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	LIMIT	UNIT		
Junction-to-Ambient (PCB Mount) ^c	R _{thJA}	40	°C/W		
Junction-to-Case (Drain)	R _{thJC}	0.4	C/VV		

Notes

- a. Duty cycle ≤ 1 %.
- b. See SOA curve for voltage derating.
- c. When mounted on 1" square PCB (FR4 material).
- d. Package limited.



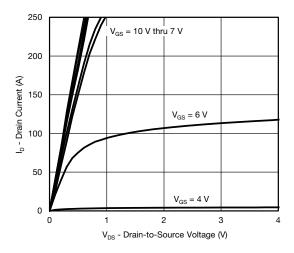
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static			•	•			
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	80	-	-	V	
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	4	V	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 250	nA	
		V _{DS} = 80 V, V _{GS} = 0 V	-	-	1	μА	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 80 V, V _{GS} = 0 V, T _J = 125 °C	-	-	150		
		V _{DS} = 80 V, V _{GS} = 0 V, T _J = 175 °C	-	-	5	mA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	120	-	-	Α	
Drain Source On State Registered 8	В	V _{GS} = 10 V, I _D = 30 A	-	0.0050	-	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 7.5 V, I _D = 20 A	-	0.0095	-		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 30 A	-	82	-	S	
Dynamic ^b							
Input Capacitance	C _{iss}		-	7910	-	pF	
Output Capacitance	C _{oss}	V _{GS} = 0 V, V _{DS} = 40 V, f = 1 MHz	-	3250	-		
Reverse Transfer Capacitance	C _{rss}		-	348	-		
Total Gate Charge ^c	Qg		-	94	141	nC	
Gate-Source Charge ^c	Q _{gs}	$V_{DS} = 40 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	31	-		
Gate-Drain Charge ^c	Q_{gd}		-	10	-		
Gate Resistance	R_g	f = 1 MHz	0.28	1.4	2.8	Ω	
Turn-On Delay Time ^c	t _{d(on)}		-	24	40		
Rise Time ^c	t _r	$V_{DD} = 40 \text{ V}, \text{ R}_{L} = 4 \Omega$	-	24	40		
Turn-Off Delay Time ^c	t _{d(off)}	$I_D\cong 10~A,~V_{GEN}=10~V,~R_g=1~\Omega$	-	34	60	ns	
Fall Time ^c	t _f		-	14	28		
Drain-Source Body Diode Ratings ar	nd Characteris	stics ^b (T _C = 25 °C)					
Pulsed Current (t = 100 μs)	I _{SM}		-	-	250	Α	
Forward Voltage ^a	V_{SD}	I _F = 10 A, V _{GS} = 0 V	-	0.8	1.5	V	
Reverse Recovery Time	t _{rr}		-	126	190	ns	
Peak Reverse Recovery Charge	I _{RM(REC)}	$I_F = 34 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$	-	5	10	Α	
Reverse Recovery Charge	Q _{rr}		-	0.315	0.475	иC	

Notes

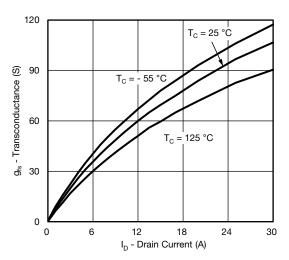
- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing. c. Independent of operating temperature.



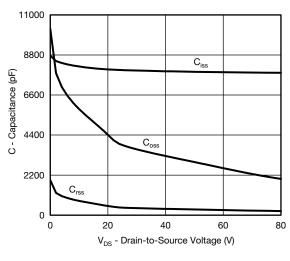
TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)



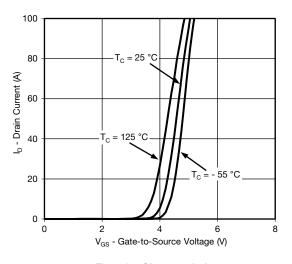
Output Characteristics



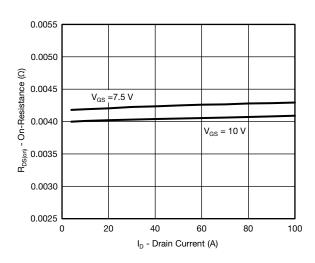
Transconductance



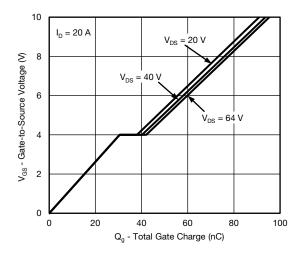
Capacitance



Transfer Characteristics



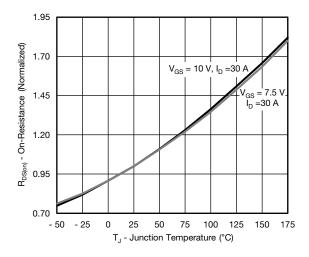
On-Resistance vs. Drain Current



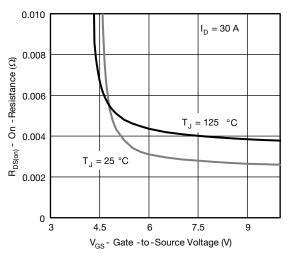
Gate Charge



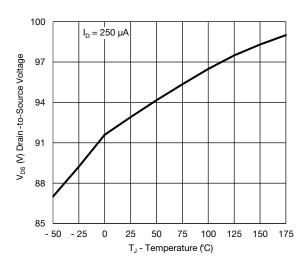
TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)



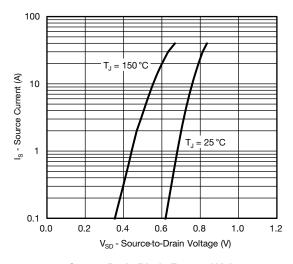
On-Resistance vs. Junction Temperature



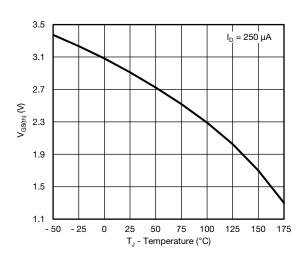
On-Resistance vs. Gate-to-Source Voltage



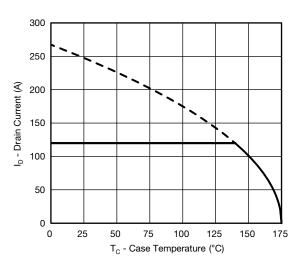
Drain Source Breakdown vs. Junction Temperature



Source Drain Diode Forward Voltage



Threshold Voltage

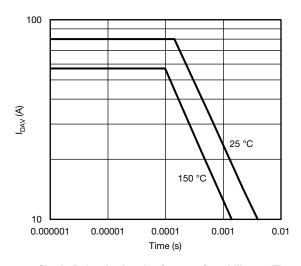


Current De-rating



10 µs

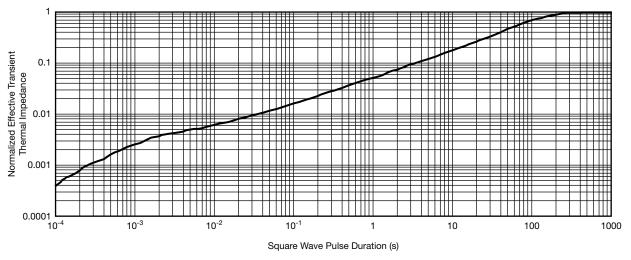
THERMAL RATINGS ($T_A = 25$ °C, unless otherwise noted)



100 I_D - Drain Current (A) 100 μs 10 Limited by Bsid 1 1 ms 0.1 $T_C = 25^{\circ}C$ 10 ms Single Pulse **BVDSS** Limited 0.01 $\begin{array}{c} 1 & 10 \\ V_{DS}\text{-} Drain-to-Source Voltage (V) \\ ^*V_{GS}> minimum \ V_{GS} \ at \ which \ R_{DS(on)} \ is \ specified \end{array}$ 0.1 100

Single Pulse Avalanche Current Capability vs. Time





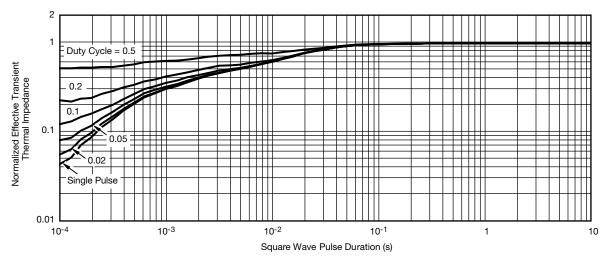
1000

I_{DM} Limited

Normalized Thermal Transient Impedance, Junction-to-Ambient



THERMAL RATINGS (T_A = 25 °C, unless otherwise noted)



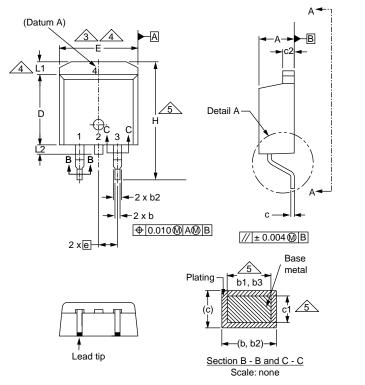
Normalized Thermal Transient Impedance, Junction-to-Case

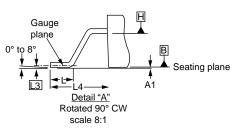
Note

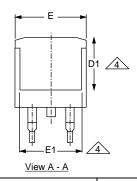
- The characteristics shown in the two graphs
 - Normalized Transient Thermal Impedance Junction to Ambient (25 °C)
 - Normalized Transient Thermal Impedance Junction to Case (25 °C) are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.



TO-263AB







	MILLIMETERS		INC	HES		
DIM.	MIN.	MAX.	MIN.	MAX.		
А	4.06	4.83	0.160	0.190		
A1	0.00	0.25	0.000	0.010		
b	0.51	0.99	0.020	0.039		
b1	0.51	0.89	0.020	0.035		
b2	1.14	1.78	0.045	0.070		
b3	1.14	1.73	0.045	0.068		
С	0.38	0.74	0.015	0.029		
c1	0.38	0.58	0.015	0.023		
c2	1.14	1.65	0.045	0.065		
D	8.38	9.65	0.330	0.380		

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D1	6.86	-	0.270	-
Е	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	-
е	2.54 BSC		0.100 BSC	
Н	14.61	15.88	0.575	0.625
L	1.78	2.79	0.070	0.110
L1	-	1.65	-	0.066
L2	-	1.78	-	0.070
L3	0.25 BSC		0.010	BSC
L4	4.78	5.28	0.188	0.208

ECN: S-82110-Rev. A, 15-Sep-08

DWG: 5970

Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.



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